

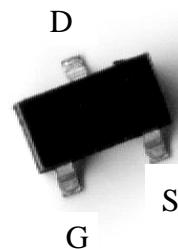
30V N-Channel Enhancement Mode MOSFET

Features:

- Simple drive requirement
- Small package outline
- ESD protected gate
- Pb-free lead plating and halogen-free package

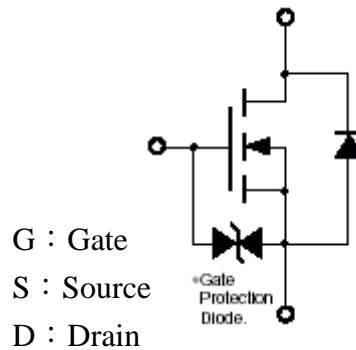
Outline

SOT-23



Symbol

KWB020N03KN3



	30V
I @ V _{GS} =10V, T _A =25°C	5.9A
R _{DSON} @V _{GS} =10V, I _D =5A	17.1mΩ (typ)
R _{DSON} @V _{GS} =4.5V, I _D =4A	21.1mΩ (typ)

Ordering Information

Device	Package	Shipping
KWB020N03KN3	SOT-23 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

Absolute Maximum Ratings ($T_a=25^\circ C$)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current @ $T_a=25^\circ C$, $V_{GS}=10V$ (Note 3)	I_D	5.9	A
Continuous Drain Current @ $T_a=70^\circ C$, $V_{GS}=10V$ (Note 3)		4.7	
Pulsed Drain Current (Notes 1, 2)	I_{DM}	34	
Maximum Power Dissipation@ $T_a=25^\circ C$ (Note 3)	P_D	1.38	W
Linear Derating Factor		0.01	W/$^\circ C$
Operating Junction and Storage Temperature Range	$T_j ; T_{stg}$	-55~+150	$^\circ C$

Note : 1. Pulse width limited by maximum junction temperature.

2. Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

3. Surface mounted on 1 in² copper pad of FR-4 board; 270°C/W when mounted on minimum copper pad

Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient, max (Note)	$R_{\theta JA}$	90	°C/W
Thermal Resistance, Junction-to-Case, max	$R_{\theta JC}$	60	

Note : Surface mounted on 1 in² copper pad of FR-4 board; 270°C/W when mounted on minimum copper pad

Electrical Characteristics ($T_j=25^\circ C$, unless otherwise noted)

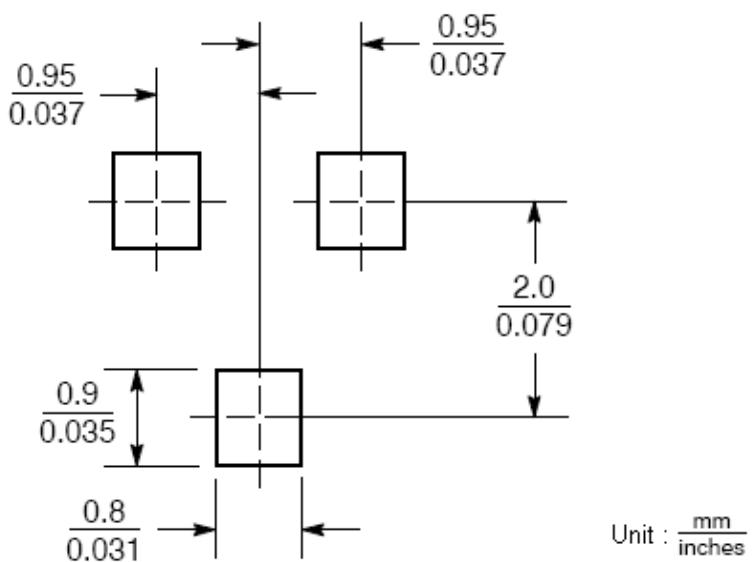
Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Static						
BV_{DSS}	30	-	-	V	$V_{GS}=0V, I_D=250\mu A$	
$V_{GS(th)}$	1	-	2.5		$V_{DS}=V_{GS}, I_D=250\mu A$	
I_{GSS}	-	-	± 10	μA	$V_{GS}=\pm 16V, V_{DS}=0V$	
ID_{SS}	-	-	1		$V_{DS}=30V, V_{GS}=0V$	
	-	-	25		$V_{DS}=24V, V_{GS}=0V(T_j=70^\circ C)$	
$*R_{DS(ON)}$	-	17.1	23	$m\Omega$	$V_{GS}=10V, I_D=5A$	
	-	21.1	28		$V_{GS}=4.5V, I_D=4A$	
$*G_{FS}$	-	4.5	-	S	$V_{DS}=10V, I_D=4A$	
Dynamic						
C_{iss}	-	450	-	pF	$V_{DS}=15V, V_{GS}=0V, f=1MHz$	
C_{oss}	-	79	-			
C_{rss}	-	60	-	ns	$V_{DS}=15V, I_D=1A, V_{GS}=10V, R_G=6\Omega$	
$t_{d(on)}$	-	5.8	-			
t_r	-	18.6	-			
$t_{d(off)}$	-	33.8	-			
t_f	-	11.8	-			

Qg	-	12	-	nC	V _{DS} =15V, I _D =5A, V _{GS} =10V
Qgs	-	1.2	-		
Qgd	-	3.8	-		

Source-Drain Diode					
*I _S	-	-	1.8	A	V _{GS} =0V, I _S =1.5A V _{GS} =0V, I _F =2.3A, dI _F /dt=100A/μs
*I _{SM}	-	-	7.2		
*V _{SD}	-	0.78	1.2	V	
T _{rr}	-	10.5	-	ns	
Q _r r	-	3.8	-	nC	

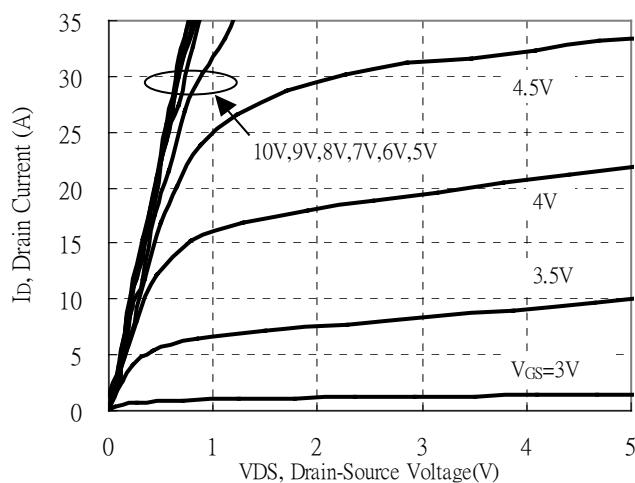
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended Soldering Footprint

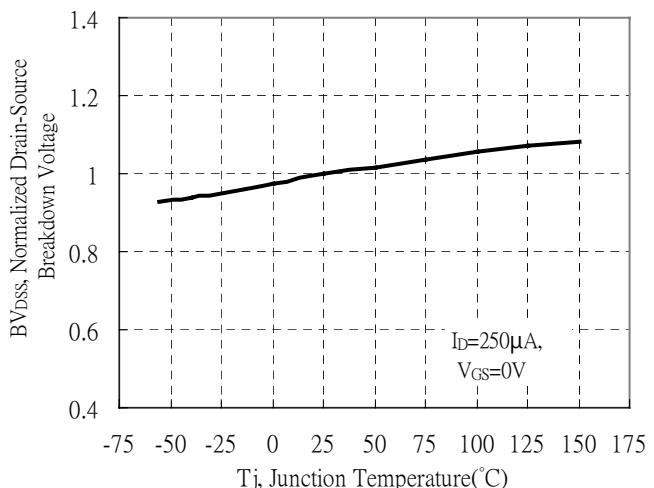


Typical Characteristics

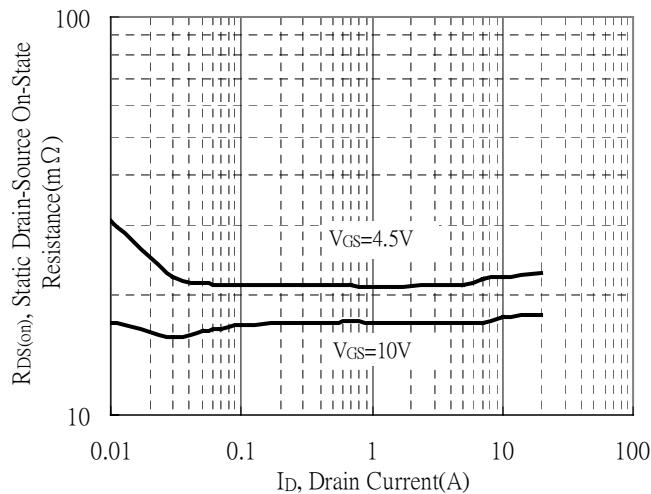
Typical Output Characteristics



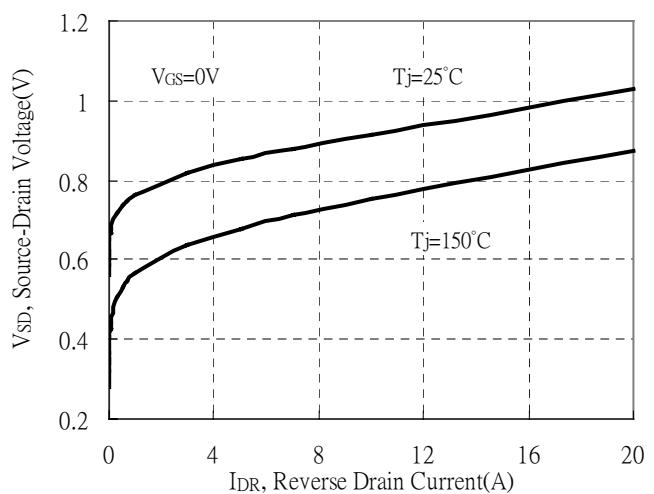
Breakdown Voltage vs Junction Temperature



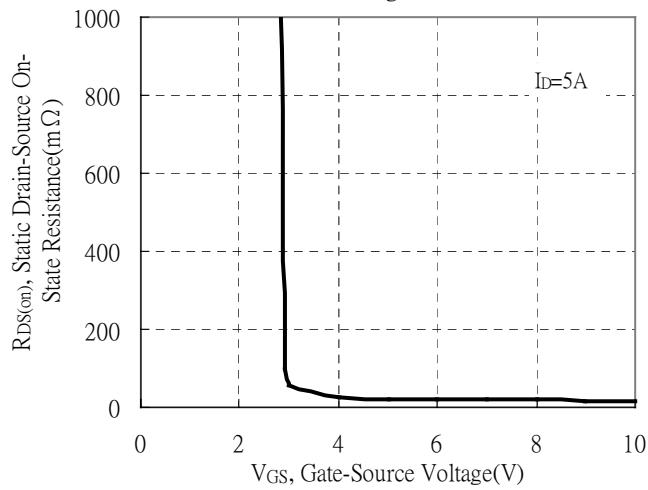
Static Drain-Source On-State resistance vs Drain Current



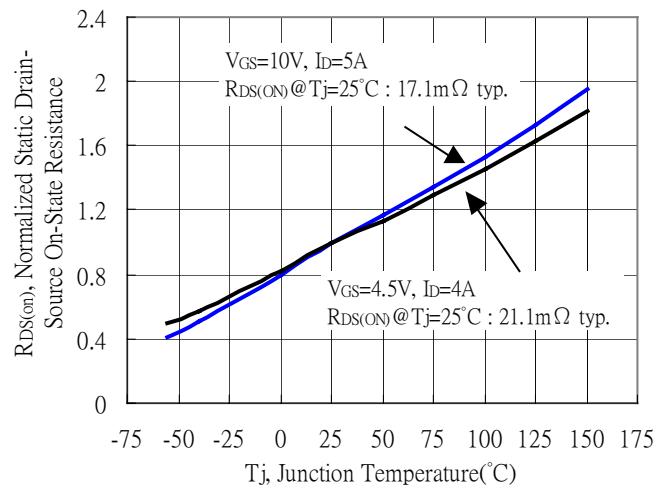
Reverse Drain Current vs Source-Drain Voltage



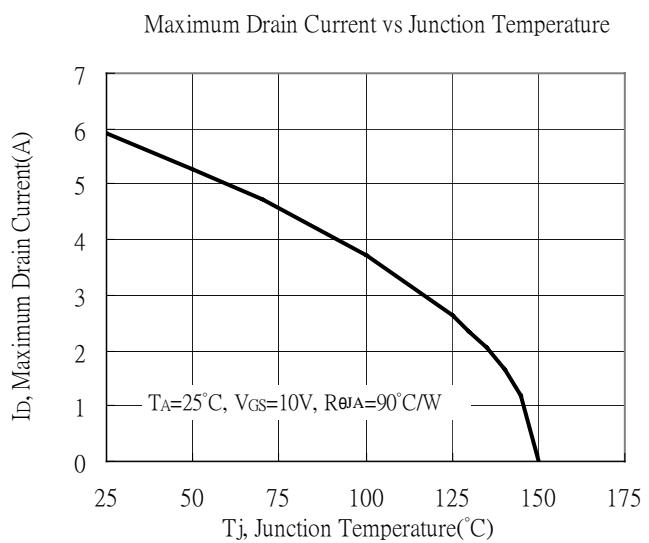
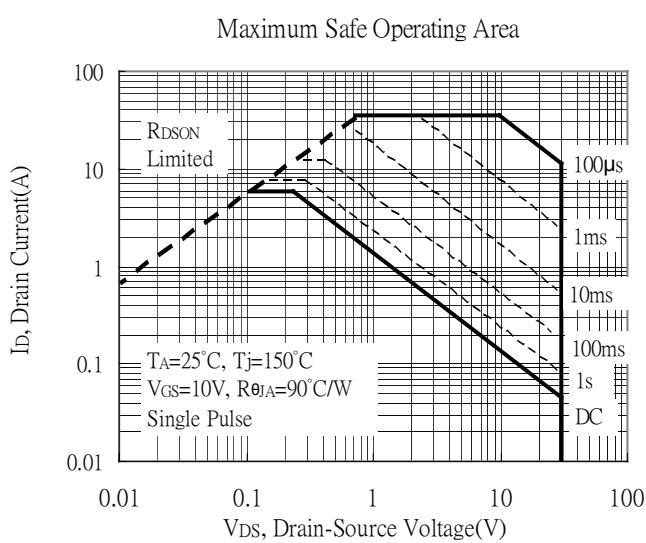
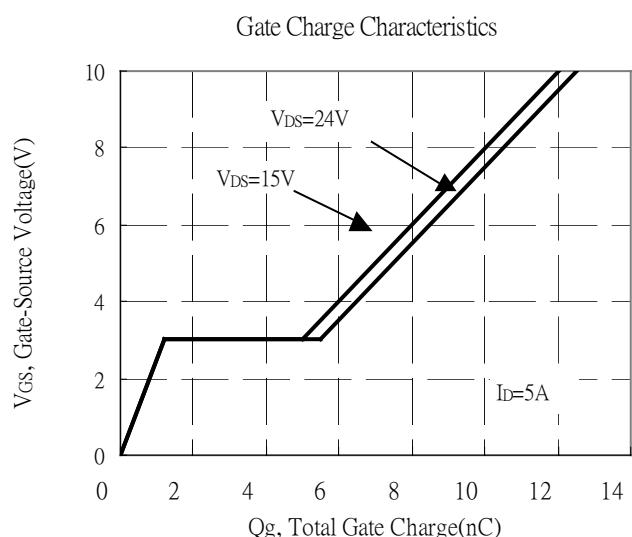
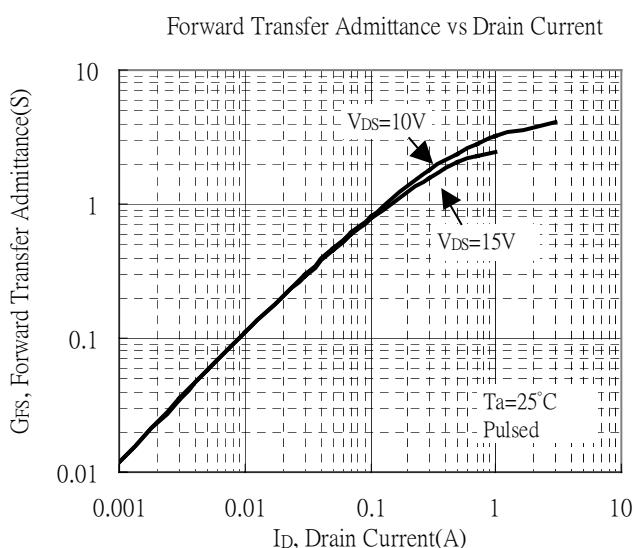
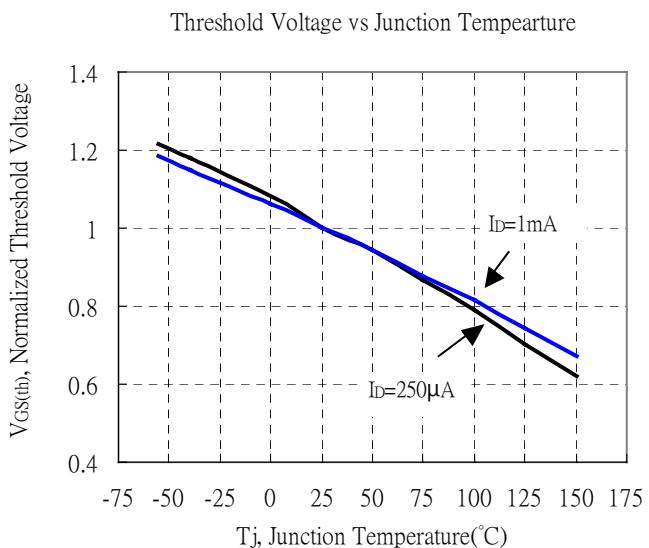
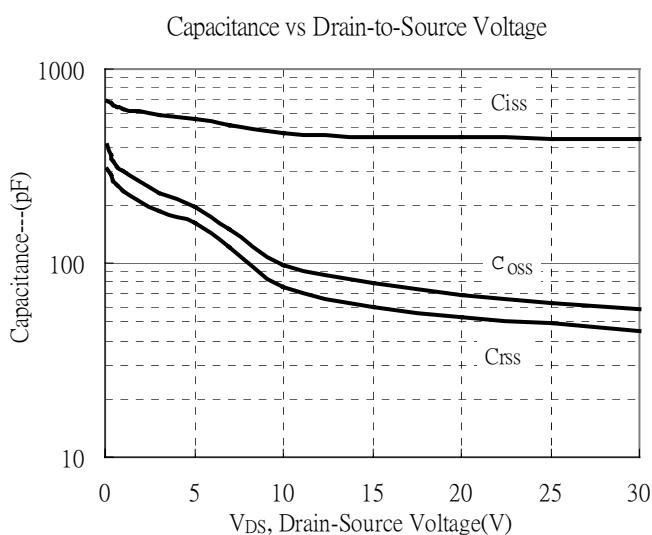
Static Drain-Source On-State Resistance vs Gate-Source Voltage



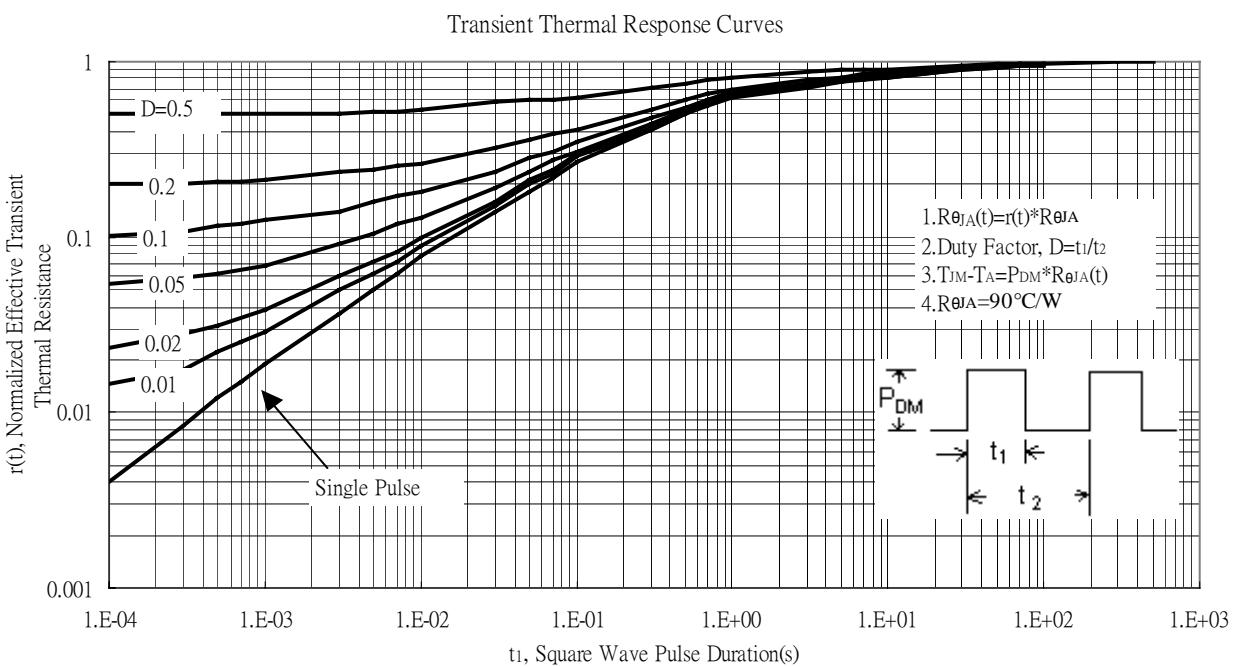
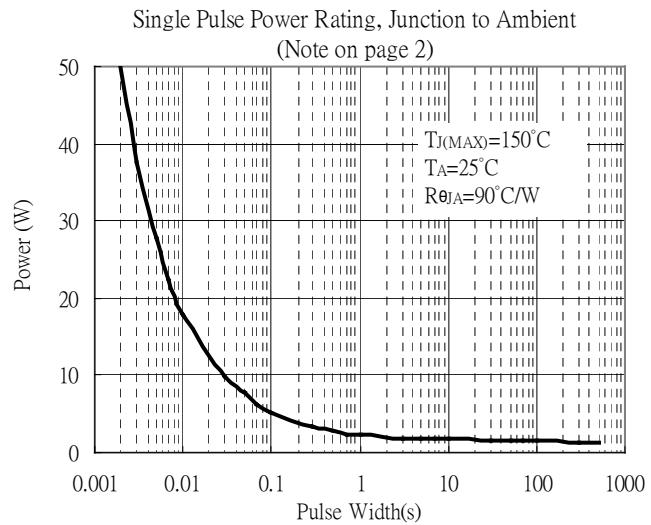
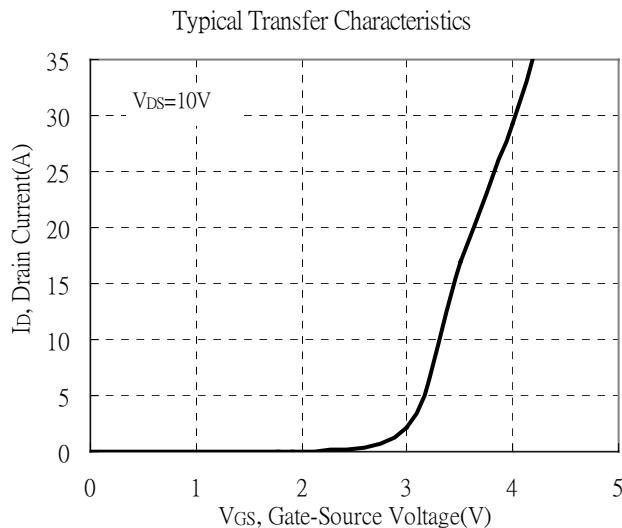
Drain-Source On-State Resistance vs Junction Temperature



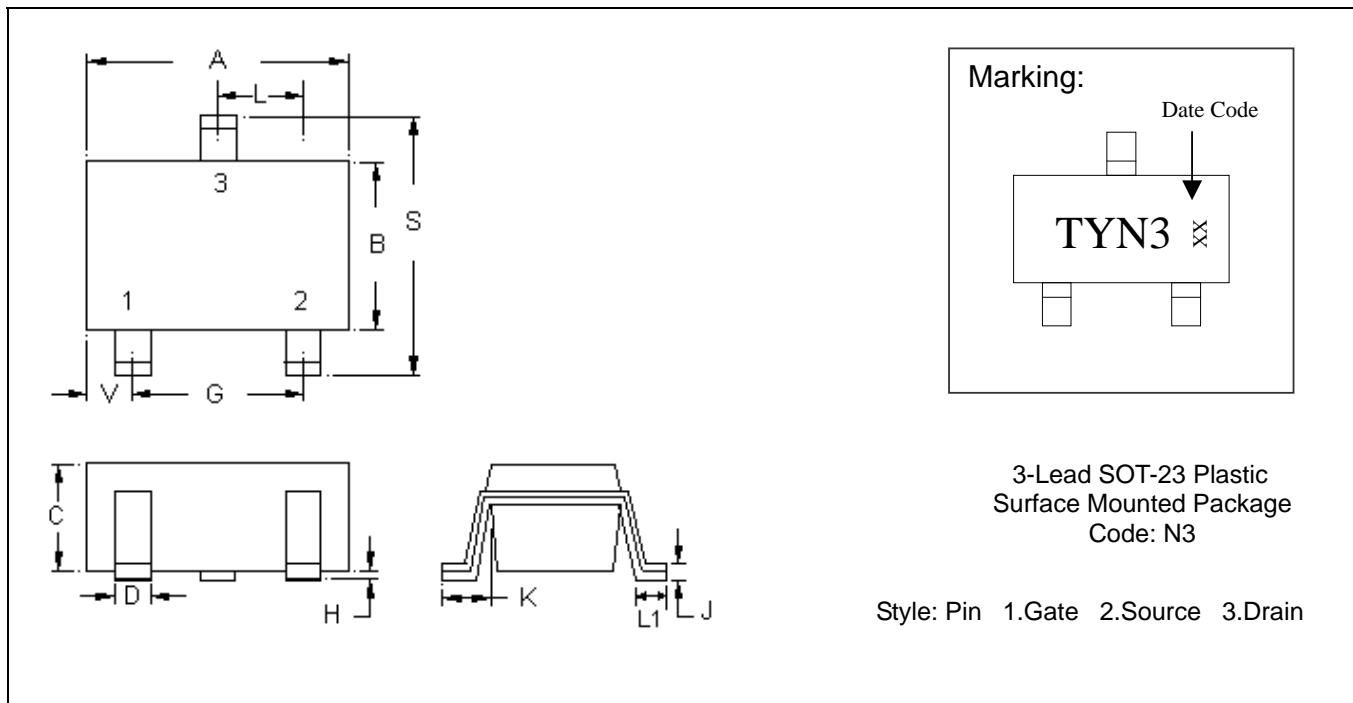
Typical Characteristics(Cont.)



Typical Characteristics(Cont.)



SOT-23 Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1102	0.1204	2.80	3.04	J	0.0032	0.0079	0.08	0.20
B	0.0472	0.0669	1.20	1.70	K	0.0118	0.0266	0.30	0.67
C	0.0335	0.0512	0.89	1.30	L	0.0335	0.0453	0.85	1.15
D	0.0118	0.0197	0.30	0.50	S	0.0830	0.1161	2.10	2.95
G	0.0669	0.0910	1.70	2.30	V	0.0098	0.0256	0.25	0.65
H	0.0000	0.0040	0.00	0.10	L1	0.0118	0.0197	0.30	0.50